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Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China







# PowerPhase, Dual N-Channel SO8FL

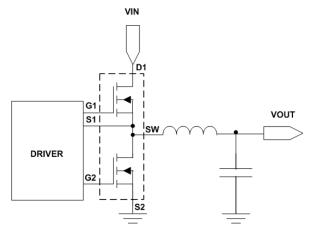
30 V, High Side 20 A / Low Side 26 A

#### **Features**

- Co-Packaged Power Stage Solution to Minimize Board Space
- Minimized Parasitic Inductances
- Optimized Devices to Reduce Power Losses
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

#### **Applications**

- DC-DC Converters
- System Voltage Rails
- Point of Load



**Figure 1. Typical Application Circuit** 

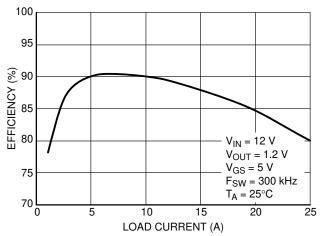


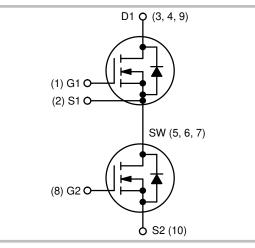
Figure 2. Typical Efficiency Performance POWERPHASEGEVB Evaluation Board



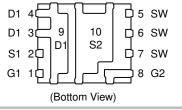
# ON Semiconductor®

#### www.onsemi.com

| V <sub>(BR)DSS</sub> | R <sub>DS(ON)</sub> MAX | I <sub>D</sub> MAX |
|----------------------|-------------------------|--------------------|
| Q1 Top FET           | 5.4 mΩ @ 10 V           | 20 A               |
| 30 V                 | 8.1 mΩ @ 4.5 V          | 20 A               |
| Q2 Bottom            | 3.1 mΩ @ 10 V           | 26 A               |
| FET<br>30 V          | 4.3 mΩ @ 4.5 V          | ∠0 A               |



#### **PIN CONNECTIONS**





DFN8 CASE 506CR



**MARKING** 

4C87N = Specific Device Code A = Assembly Location

′ = Year

W = Work Week
ZZ = Lot Traceability

#### **ORDERING INFORMATION**

See detailed ordering and shipping information on page 10 of this data sheet.

# **MAXIMUM RATINGS** ( $T_J = 25^{\circ}C$ unless otherwise stated)

| Parameter   |        | Symbol                 | Value | Unit                              |             |     |  |
|---|--------|------------------------|-------|-----------------------------------|-------------|-----|--|
| Drain-to-Source Voltage   | Q1     | V <sub>DSS</sub>       | 30    | ٧                                 |             |     |  |
| Drain-to-Source Voltage   | Q2     |                        |       |                                   |             |     |  |
| Gate-to-Source Voltage  | Q1     | V <sub>GS</sub>        | ±20   | V                                 |             |     |  |
| Gate-to-Source Voltage  |        |                        | Q2    |                                   |             |     |  |
| Continuous Drain Current R <sub>0JA</sub> (Note 1)                                  |        | T <sub>A</sub> = 25°C  | Q1    | I <sub>D</sub>                    | 15.4        |     |  |
|   |        | T <sub>A</sub> = 85°C  | 1     |                                   | 11.1        | 1.  |  |
|   |        | T <sub>A</sub> = 25°C  | Q2    |                                   | 19.5        | A   |  |
|   |        | T <sub>A</sub> = 85°C  | 1     |                                   | 14.1        |     |  |
| Power Dissipation   | 1      | T <sub>A</sub> = 25°C  | Q1    | $P_{D}$                           | 1.89        | W   |  |
| RθJA (Note 1)   |        |                        | Q2    |                                   |             |     |  |
| Continuous Drain Current $R_{\theta JA} \le 10 \text{ s (Note 1)}$                  | 1      | T <sub>A</sub> = 25°C  | Q1    | I <sub>D</sub>                    | 21.0        |     |  |
|   |        | T <sub>A</sub> = 85°C  |       |                                   | 15.1        | A A |  |
|   | Steady | T <sub>A</sub> = 25°C  | Q2    |                                   | 26.6        |     |  |
|   | State  | T <sub>A</sub> = 85°C  | 1     |                                   | 19.2        |     |  |
| Power Dissipation   | 1      | T <sub>A</sub> = 25°C  | Q1    | $P_{D}$                           | 3.51        | W   |  |
| $R_{\theta JA} \le 10 \text{ s (Note 1)}$   |        |                        | Q2    |                                   |             |     |  |
| Continuous Drain Current  | 1      | T <sub>A</sub> = 25°C  | Q1    | I <sub>D</sub>                    | 11.7        |     |  |
| R <sub>θJA</sub> (Note 2)   |        | T <sub>A</sub> = 85°C  | 1     |                                   | 8.5         | 1.  |  |
|   |        | T <sub>A</sub> = 25°C  | Q2    |                                   | 14.9        | A   |  |
|   |        | T <sub>A</sub> = 85°C  | 1     |                                   | 10.7        | 7   |  |
| Power Dissipation   | 1      | T <sub>A</sub> = 25 °C | Q1    | $P_{D}$                           | 1.10        | W   |  |
| R <sub>θJA</sub> (Note 2)   |        |                        | Q2    |                                   |             |     |  |
| Pulsed Drain Current  | •      | T <sub>A</sub> = 25°C  | Q1    | I <sub>DM</sub>                   | 160         | Α   |  |
|   |        | t <sub>p</sub> = 10 μs | Q2    |                                   | 260         |     |  |
| Operating Junction and Storage Temperature  |        | •                      | Q1    | T <sub>J</sub> , T <sub>STG</sub> | -55 to +150 | °C  |  |
|   | Q2     |                        |       |                                   |             |     |  |
| Source Current (Body Diode)   |        |                        |       | I <sub>S</sub>                    | 10          | Α   |  |
|   | Q2     |                        | 10    |                                   |             |     |  |
| Drain to Source DV/DT   |        | dV/dt                  | 6     | V/ns                              |             |     |  |
| Single Pulse Drain-to-Source Avalanche Energy (TJ                                   | Q1     | EAS                    | 20    | mJ                                |             |     |  |
| $V_{DD} = 50 \text{ V}, V_{GS} = 10 \text{ V}, L = 0.1 \text{ mH}, R_G = 25 \Omega$ | Q2     | EAS                    | 45    | 1                                 |             |     |  |
| Lead Temperature for Soldering Purposes (1/8" from case for 10 s)                   |        | T <sub>L</sub>         | 260   | °C                                |             |     |  |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Surface—mounted on FR4 board using 1 sq—in pad, 2 oz Cu.

2. Surface—mounted on FR4 board using the minimum recommended pad size of 100 mm<sup>2</sup>.

#### THERMAL RESISTANCE MAXIMUM RATINGS

| Parameter                                      | Symbol          | Value | Unit |
|--|-----------------|-------|------|
| Junction-to-Ambient - Steady State (Note 3)    | $R_{\theta JA}$ | 66.0  |      |
| Junction-to-Ambient - Steady State (Note 4)    | $R_{\theta JA}$ | 113.7 | °C/W |
| Junction–to–Ambient – (t $\leq$ 10 s) (Note 3) | $R_{	heta JA}$  | 35.6  |      |

#### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

| Parameter                                  | FET  | Symbol                                   | Test Co  | ondition               | Min | Тур  | Max | Unit |
|--|------|--|--|------------------------|-----|------|-----|------|
| OFF CHARACTERISTICS                        | •    | •  |  |                        | •   | •    |     | •    |
| Drain-to-Source Break-                     | Q1   | , I                                      | $V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$                    |                        | 30  |      |     | V    |
| down Voltage                               | Q2   | V <sub>(BR)DSS</sub>                     |  |                        | 30  |      |     |      |
| Drain-to-Source Break-                     | Q1   | V <sub>(BR)DSS</sub>                     |  |                        |     | 15.8 |     | mV / |
| down Voltage Temperature<br>Coefficient    | Q2   | / T <sub>J</sub>                         |  |                        |     | 15.3 |     | °C   |
| Zero Gate Voltage Drain                    | Q1   | I <sub>DSS</sub>                         | V <sub>GS</sub> = 0 V,   | T <sub>J</sub> = 25°C  |     |      | 1   |      |
| Current                                    |      |  | $V_{DS} = 24 \text{ V}$  | T <sub>J</sub> = 125°C |     |      | 10  | μΑ   |
|  | Q2   |  | $V_{GS} = 0 \text{ V},$<br>$V_{DS} = 24 \text{ V}$               | T <sub>J</sub> = 25°C  |     |      | 1   | , pu |
| Gate-to-Source Leakage                     | Q1   | I <sub>GSS</sub>                         | $V_{GS} = 0 V, V$  | VDS = +20 V            |     |      | 100 |      |
| Current                                    |      |  |  |                        |     | 100  | nA  |      |
| ON CHARACTERISTICS (Not                    | e 5) |  |  |                        |     |      |     |      |
| Gate Threshold Voltage                     | Q1   | V <sub>GS(TH)</sub>                      | $V_{GS} = VDS$ , $I_D = 250 \mu A$                               |                        | 1.3 |      | 2.2 | V    |
|  | Q2   |  |  | 1.3                    |     | 2.2  |     |      |
| Negative Threshold Temperature Coefficient | Q1   | V <sub>GS(TH)</sub> /<br>T <sub>.l</sub> |  |                        |     | 5.0  |     | mV / |
| ature Goefficient                          | Q2   | IJ                                       |  |                        |     | 5.1  |     | °C   |
| Drain-to-Source On Resistance              | Q1   | R <sub>DS(on)</sub>                      | $V_{GS} = 10 \text{ V}$  | I <sub>D</sub> = 30 A  |     | 4.3  | 5.4 |      |
| ance                                       |      |  | $V_{GS} = 4.5 \text{ V}$   | I <sub>D</sub> = 18 A  |     | 6.5  | 8.1 |      |
|  | Q2   | ] [                                      | $V_{GS} = 10 \text{ V}$  | I <sub>D</sub> = 30 A  |     | 2.5  | 3.1 | mΩ   |
|  |      |  | V <sub>GS</sub> = 4.5 V I <sub>D</sub> = 30 A                    |                        |     | 3.4  | 4.3 | 1    |
| CAPACITANCES                               |      |  |  |                        |     |      |     |      |
| Input Canacitanas                          | Q1   | Cons                                     |  |                        |     | 1252 |     |      |
| Input Capacitance                          | Q2   | C <sub>ISS</sub>                         |  |                        |     | 1939 |     |      |
| Output Canacitanas                         | Q1   | Cons                                     | $V_{GS} = 0 \text{ V, f} = 1 \text{ MHz, V}_{DS} = 15 \text{ V}$ |                        |     | 610  |     | pF   |
| Output Capacitance                         | Q2   | OSS                                      |  |                        |     | 1055 |     |      |
| Reverse Capacitance                        | Q1   | Casa                                     |  |                        |     | 129  |     |      |
| Tieverse Oapacitatioe                      | Q2   | C <sub>RSS</sub>                         |  |                        |     | 49   |     | 1    |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

5. Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.

6. Switching characteristics are independent of operating junction temperatures.

Surface–mounted on FR4 board using 1 sq-in pad, 2 oz Cu.
 Surface–mounted on FR4 board using the minimum recommended pad size of 100 mm<sup>2</sup>.

# **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

| Parameter                     | FET              | Symbol  | Test Co   | ondition  | Min  | Тур  | Max      | Unit     |
|-------------------------------|------------------|---|---|---|------|------|----------|----------|
| CHARGES, CAPACITANCE          | S & GATE         | RESISTANC   | E   |   | •    |      | -        |          |
| T : 10 : 01                   | Q1               | _   |   |   |      | 10.9 |          |          |
| Total Gate Charge             | Q2               | $Q_{G(TOT)}$  | $Q_{G(TOT)}$  |   |      | 13.8 |          | 1        |
| There are also Octor Observes | Q1               | _   |   |   |      | 1.2  |          | 1        |
| Threshold Gate Charge         | Q2               | Q <sub>G(TH)</sub>  | V 45VV  | 45.1/.1 00.4                                    |      | 2.0  |          |          |
| 0-1- 1- 0 01                  | Q1               | 0   | $v_{GS} = 4.5 \text{ V}, v_{DS}$  | $= 15 \text{ V}; I_D = 30 \text{ A}$            |      | 3.4  |          | nC       |
| Gate-to-Source Charge         | Q2               | $Q_GS$  |   |   |      | 5.5  |          |          |
| Oata ta Duala Obanna          | Q1               | 0   |   |   |      | 5.4  |          |          |
| Gate-to-Drain Charge          | Q2               | $Q_GD$  |   |   |      | 3.6  |          |          |
| Total Cata Chausa             | Q1               | 0   | V 10.V.V  | 45 V. L. 00 A                                   |      | 22.2 |          | 0        |
| Total Gate Charge             | Q2               | $Q_{G(TOT)}$  | $V_{GS} = 10 \text{ V}, V_{DS}$   | = 15 V; I <sub>D</sub> = 30 A                   |      | 30.3 |          | nC       |
| Osta Basistana                | Q1               | $R_{G}$   | -   | 0500  |      | 1.0  |          |          |
| Gate Resistance               | Q2               |   | IA =  | 25°C  |      | 1.0  |          | Ω        |
| SWITCHING CHARACTERI          | STICS (No        | te 6)   |   |   |      |      |          |          |
| Town On Dalay Time            | Q1               |   | t <sub>d</sub> (ON)   |   |      | 8.9  |          |          |
| Turn-On Delay Time            | Q2               | <sup>t</sup> d(ON)  |   |   |      | 10.6 |          |          |
| Q1   Q2                       | Q1               |   |   |   |      | 21.2 |          |          |
|                               | - t <sub>r</sub> | $V_{GS}$ = 4.5 V, $V_{DS}$ = 15 V, $I_{D}$ = 15 A, $R_{G}$ = 3.0 $\Omega$ |   |   | 4.6  |      |          |          |
| T 0"D   T                     | Q1               |   | $I_{\rm D} = 15  {\rm A},$  | $R_G = 3.0 \Omega$                              |      | 15.3 |          | ns       |
| Turn-Off Delay Time           | Q2               | t <sub>d(OFF)</sub>   |   |   |      | 21   |          |          |
| 5 U.T.                        | Q1               |   |   |   |      | 4.4  |          |          |
| Fall Time                     | Q2               | t <sub>f</sub>  |   |   |      | 4.9  |          | 1        |
| SWITCHING CHARACTERI          | STICS (No        | te 6)   |   |   |      |      |          |          |
| Town On Dalay Time            | Q1               |   |   |   |      | 6.7  |          |          |
| Turn-On Delay Time            | Q2               | t <sub>d(ON)</sub>  |   |   |      | 8.1  |          | 1        |
| Disc. Time                    | Q1               |   |   |   |      | 19.5 |          | 1        |
| Rise Time                     | Q2               | t <sub>r</sub>  | V <sub>GS</sub> = 10 V.   | $V_{GS} = 10 \text{ V}, V_{DS} = 15 \text{ V},$ |      | 15   |          | 1        |
| T 0"D   T                     | Q1               |   | $t_{D} = 15 \text{ A}, R_{G} = 3.0 \Omega$  |   |      | 20.1 |          | ns       |
| Turn-Off Delay Time           | Q2               | t <sub>d(OFF)</sub>   |   |   |      | 26.2 |          |          |
|                               | Q1               |   |   |   |      | 2.8  |          |          |
| Fall Time                     | Q2               | t <sub>f</sub>  |   |   |      | 3.1  |          |          |
| DRAIN-SOURCE DIODE CI         | HARACTE          | RISTICS   |   |   | -    | -    | <u>-</u> | <u>-</u> |
|                               |                  |   | $V_{GS} = 0 \text{ V}.$   | T <sub>J</sub> = 25°C                           |      | 0.82 |          |          |
|                               |                  |   | $V_{GS} = 0 V$ ,<br>$I_S = 10 A$  | T <sub>J</sub> = 125°C                          |      | 1.15 |          | 1        |
| Forward Voltage               |                  | $V_{SD}$  | $V_{GS} = 0 V_{c}$  | T <sub>J</sub> = 25°C                           |      | 0.8  |          | V        |
|                               | Q2               |   | $V_{GS} = 0 \text{ V},$ $I_{S} = 10 \text{ A}$ $I_{J} = 25^{\circ}\text{C}$ $I_{J} = 125^{\circ}\text{C}$ |   | 1.10 |      |          | 1        |

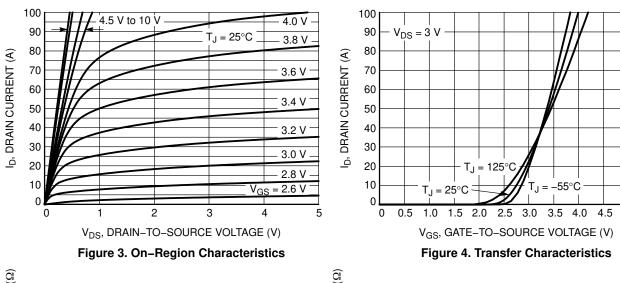
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 5. Pulse Test: pulse width  $\leq 300~\mu s$ , duty cycle  $\leq 2\%$ . 6. Switching characteristics are independent of operating junction temperatures.

# **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

| Parameter               | FET    | Symbol          | nbol Test Condition  |  | Тур  | Max | Unit |
|-------------------------|--------|-----------------|--|--|------|-----|------|
| DRAIN-SOURCE DIODE CHA  | ARACTE | RISTICS         |  |  |      |     |      |
| Daviera Daviera Tima    | Q1     |                 |  |  | 29.1 |     |      |
| Reverse Recovery Time   | Q2     | t <sub>RR</sub> |  |  | 40.2 |     | ns   |
| O                       | Q1     |                 |  |  | 14.2 |     |      |
| Charge Time             | Q2     | ta              |  |  | 19.5 |     |      |
| D'a da anna Tiana       | Q1     | 41-             | $V_{GS} = 0 \text{ V}, d_{IS}/d_t = 100 \text{ A/}\mu\text{s}, I_S = 30 \text{ A}$ |  | 14.6 |     |      |
| Discharge Time          | Q2     | tb              |  |  | 20.6 |     |      |
| Daviera Daviera Chara   | Q1     | 0               | Q <sub>RR</sub>  |  | 21   |     | 0    |
| Reverse Recovery Charge | Q2     | <b>Q</b> RR     |  |  | 39   |     | nC   |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 5. Pulse Test: pulse width  $\leq 300~\mu s$ , duty cycle  $\leq 2\%$ . 6. Switching characteristics are independent of operating junction temperatures.

#### **TYPICAL CHARACTERISTICS - Q1**



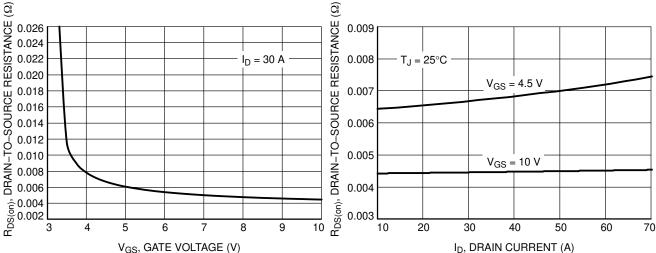


Figure 5. On–Resistance vs. Gate–to–Source Voltage

1.7

0.7

-50

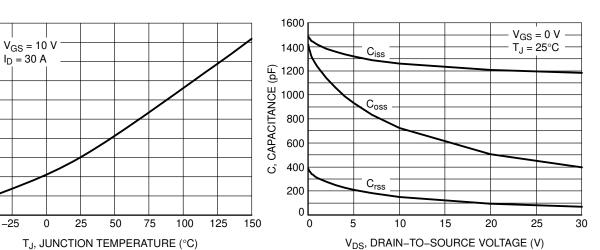


Figure 7. On–Resistance Variation with Temperature

Figure 8. Capacitance Variation

Figure 6. On-Resistance vs. Drain Current and

**Gate Voltage** 

#### **TYPICAL CHARACTERISTICS - Q1**

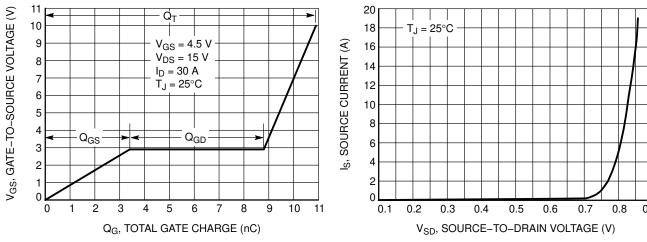
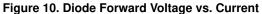


Figure 9. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge



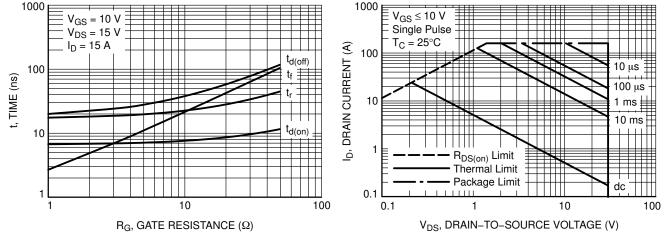


Figure 11. Resistive Switching Time Variation vs. Gate Resistance

Figure 12. Maximum Rated Forward Biased Safe Operating Area

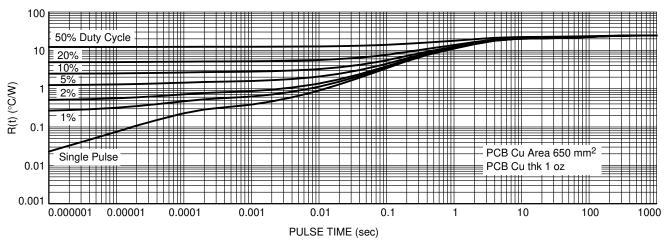


Figure 13. Thermal Characteristics

#### **TYPICAL CHARACTERISTICS - Q2**

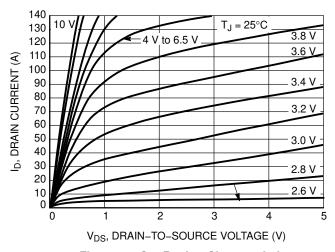


Figure 14. On-Region Characteristics

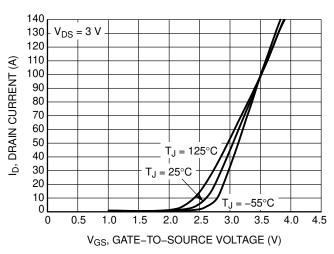


Figure 15. Transfer Characteristics

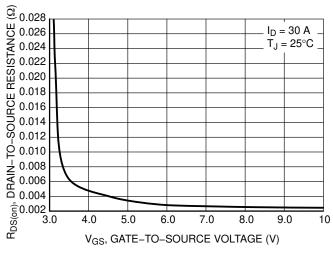


Figure 16. On-Resistance vs. V<sub>GS</sub>

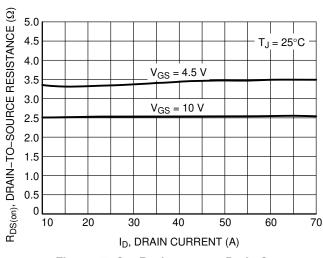


Figure 17. On–Resistance vs. Drain Current and Gate Voltage

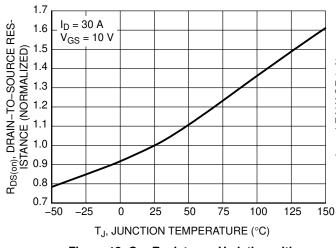


Figure 18. On–Resistance Variation with Temperature

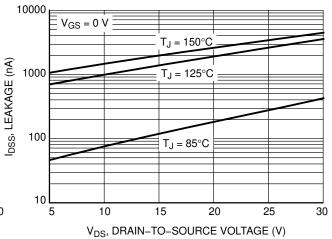
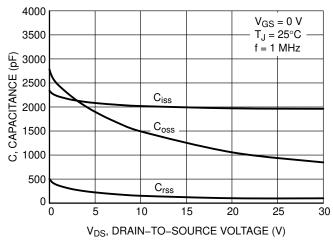


Figure 19. Drain-to-Source Leakage Current vs. Voltage

# **TYPICAL CHARACTERISTICS - Q2**



11 V<sub>GS</sub>, GATE-TO-SOURCE VOLTAGE (V)  $Q_T$ 10 9  $T_J = 25^{\circ}C$  $V_{DS} = 15 \text{ V}$ 8  $V_{GS} = 4.5 \text{ V}$ 7  $I_{D} = 30 \text{ A}$ 6 5 4  $Q_{gd}$  $Q_{gs}$ 3 2 0 | 8 10 12 14  $Q_g$ , TOTAL GATE CHARGE (nC)

Figure 20. Capacitance Variation

Figure 21. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

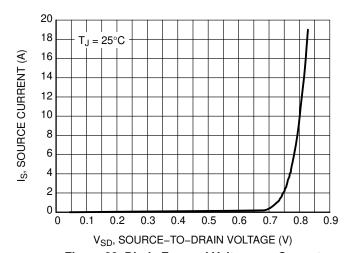


Figure 22. Diode Forward Voltage vs. Current

#### **TYPICAL CHARACTERISTICS - Q2**

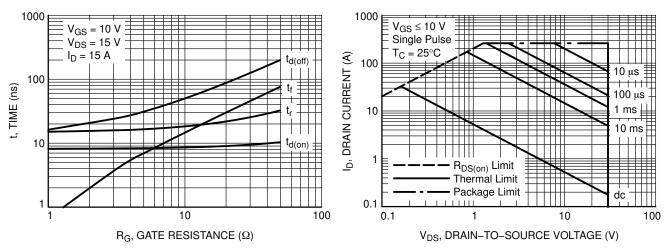


Figure 23. Resistive Switching Time Variation vs. Gate Resistance

Figure 24. Maximum Rated Forward Biased Safe Operating Area

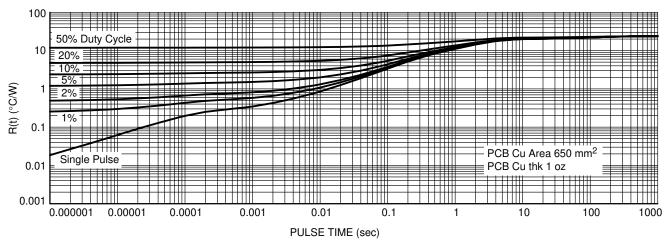


Figure 25. Thermal Characteristics

#### **ORDERING INFORMATION**

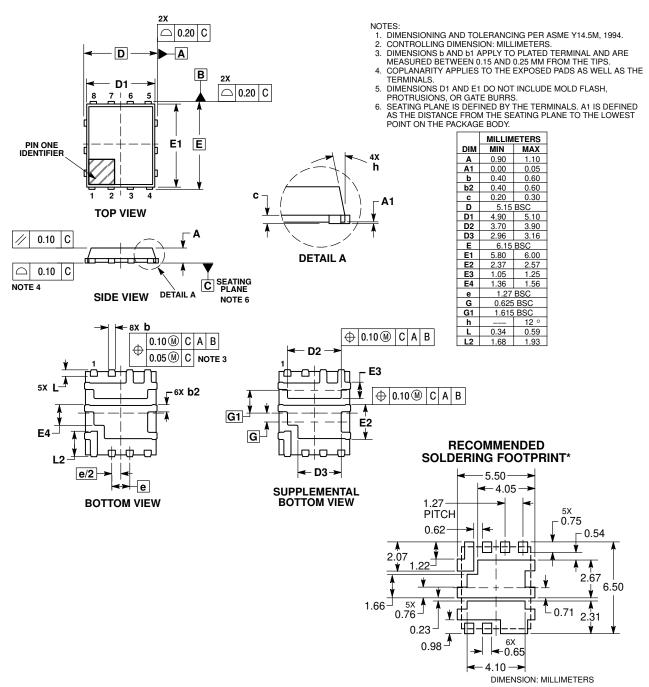
| Device        | Package           | Shipping <sup>†</sup> |
|---------------|-------------------|-----------------------|
| NTMFD4C87NT1G | DFN8<br>(Pb-Free) | 1500 / Tape & Reel    |
| NTMFD4C87NT3G | DFN8<br>(Pb-Free) | 5000 / Tape & Reel    |

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### PACKAGE DIMENSIONS

#### DFN8 5x6, 1.27P PowerPhase FET

CASE 506CR ISSUE C



<sup>\*</sup>For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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